# RENESAS

# DATASHEET

### ISL29033

Ultra-Low Lux, Low Power, Integrated Digital Ambient Light Sensor with Interrupt Function

FN7656 Rev 5.00 September 28, 2016

The ISL29033 is an integrated ambient and infrared light-to-digital converter with  $I^2C$  (SMBus Compatible) interface. Its advanced, self-calibrated photodiode array emulates human eye response with excellent IR rejection. The on-chip 16-bit ADC is capable of rejecting 50Hz and 60Hz flicker caused by artificial light sources. The lux range select feature allows users to program the lux range for optimized counts/lux. Power consumption can be reduced to less than 0.3µA when powered down.

The ISL29033 supports a software and hardware interrupt that remains asserted until the host clears it through the  $I^2C$  interface. The function of ADC conversion continues without stopping after interrupt is asserted.

Designed to operate on supplies from 2.25V to 3.63V with an  $I^2C$  supply from 1.7V to 3.63V, the ISL29033 is specified for operation across the -40 °C to +85 °C ambient temperature range.

## **Related Literature**

- For a full list of related documents, visit our web page
- ISL29033 product page

### **Features**

- · Ambient light sensing
- Simple output code directly proportional to lux
- Variable conversion resolution up to 16 bits
- · Adjustable sensitivity up to 520 counts per lux
- Measurement range: 0.0019 to 8,000lux with four selectable ranges
- Program interrupt feature
- · Light sensor close to human eye response
  - Excellent light sensor IR and UV rejection
- 75µA maximum operating current
  - 0.3µA maximum shutdown current
- 6 Ld 2.0mmx2.1mmx0.7mm ODFN package

### Applications

- Display and keypad dimming adjustment for:
  - Mobile devices: smart phone, PDA, GPS
  - Computing devices: notebook PC, webpad
  - Consumer devices: LCD-TV, digital picture frame, digital camera
- Industrial and medical light sensing

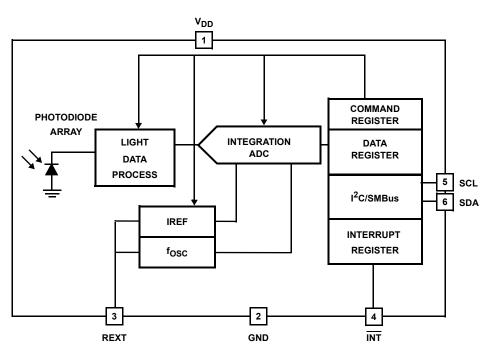
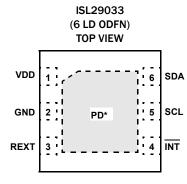


FIGURE 1. BLOCK DIAGRAM



### **Pin Configuration**



\*EXPOSED PAD CAN BE CONNECTED TO GND OR ELECTRICALLY ISOLATED

### **Pin Descriptions**

PIN NUMBER	PIN NAME	DESCRIPTION
PD	PD	Thermal Pad (connect to GND, or float)
1	VDD	Positive supply: 2.25V to 3.63V
2	GND	Ground
3	REXT	External resistor pin for ADC reference; connect this pin to ground through a (nominal) $499k\Omega$ resistor.
4	INT	Interrupt pin: low for interrupt alarming. INT pin is open-drain. INT remains asserted until the interrupt flag status bit is reset.
5	SCL	I <sup>2</sup> C serial clock
6	SDA	I <sup>2</sup> C serial data

## **Ordering Information**

PART NUMBER (Notes 1, 2, 3, 4)	TEMP. RANGE (°C)	TAPE AND REEL (UNITS)	PACKAGE (RoHS COMPLIANT)	PKG. DWG. #
ISL29033IR0Z-T7	-40 to +85	3k	6 Ld ODFN	L6.2x2.1
ISL29033IROZ-EVALZ	Evaluation Board		•	·

NOTES:

1. Refer to TB347 for details on reel specifications.

 These Intersil Pb-free plastic packaged products employ special Pb-free material sets; molding compounds/die attach materials and NiPdAu plate - e4 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

3. For Moisture Sensitivity Level (MSL), see device information page for ISL29033. For more information on MSL, see Tech Brief TB477.

4. The part marking is located on the bottom of the part.



#### Absolute Maximum Ratings (T<sub>A</sub> = +25°C)

VDD Supply Voltage between VDD and GND4.0	V
I <sup>2</sup> C Bus Pin Voltage (SCL, SDA)	V
I <sup>2</sup> C Bus Pin Current (SCL, SDA)	Α
R <sub>EXT</sub> Pin Voltage0.2V to VDD + 0.5	v
INT Pin Voltage	v
INT Pin Current	Α
ESD Rating	
Human Body Model 3k	V
INT Pin Current	A

#### **Thermal Information**

Thermal Resistance (Typical)	θ <b>JA</b> (°C/W)
6 Ld ODFN ( <u>Note 5</u> )	88
Maximum Die Temperature	+90°C
Storage Temperature40	0°C to +100°C
Operating Temperature4	40°C to +85°C
Pb-Free Reflow Profile	see <u>TB477</u>

#### **Recommended Operating Conditions**

Temperature	40°C to +85°C
Supply Voltage	

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

#### NOTE:

5. θ<sub>JA</sub> is measured in free air with the component mounted on a high effective thermal conductivity test board with "direct attach" features. See Tech Brief <u>TB477</u>.

#### MIN MAX DESCRIPTION **TEST CONDITIONS** PARAMETER (Note 6) TYP (Note 6) UNIT **Power Supply Range** 2.25 3.63 ۷ VDD 75 μΑ Supply Current 65 IDD Supply Current when Powered Down 0.01 Software disabled or auto power-down 0.3 μA IDD1 Supply Voltage Range for I<sup>2</sup>C Interface 1.70 3.63 v V<sub>I2C</sub> Internal Oscillator Frequency 600 670 740 kHz fosc ADC Integration/Conversion Time 16-bit ADC data 100 ms t<sub>INT</sub> I<sup>2</sup>C Clock Rate Range F<sub>I2C</sub> 1 to kHz 400 DATA\_0 **Count Output when Dark** E = 0 lux, Range 1 (125 lux)1 5 Counts DATA\_F Full Scale ADC Code 65535 Counts ΔDATA **Count Output Variation Over Three Light** Ambient light sensing $\pm 10$ % DATA Sources: Fluorescent, Incandescent and Sunlight Light Count Output with LSB of DATA\_1 E = 37.5 lux, fluorescent light (Note 7), 16000 20000 24000 Counts 0.0019 lux/Count ambient light sensing, Range 1 (125 lux) Light Count Output with LSB of E = 37.5 lux, fluorescent light (Note 7),5000 DATA\_2 Counts 0.0075 lux/Count ambient light sensing, Range 2 (500 lux) DATA\_3 Light Count Output with LSB of 0.03 lux/Count E = 37.5 lux, fluorescent light (<u>Note 7</u>), 1250 Counts ambient light sensing, Range 3 (2k lux) DATA 4 Light Count Output with LSB of 0.12 lux/Count E = 37.5 lux, fluorescent light (<u>Note 7</u>), 312 Counts ambient light sensing, Range 4 (8k lux) DATA\_IR1 E = 20 lux solar light (<u>Note 8</u>), 16000 20000 24000 Counts Infrared Count Output ambient light sensing, Range 1 (125 lux) DATA\_IR2 Infrared Count Output E = 20 lux solar light (Note 8), 5000 Counts ambient light sensing, Range 2 (500 lux) 1250 DATA IR3 Infrared Count Output E = 20 lux solar light (Note 8),Counts ambient light sensing, Range 3 (2000 lux) DATA\_IR4 **Infrared Count Output** E = 20 lux solar light (<u>Note 8</u>),312 Counts ambient light sensing, Range 4 (8000 lux)

#### **Electrical Specifications** $V_{DD} = 3.0V$ , $T_A = +25$ °C, $R_{EXT} = 499k\Omega$ 1% tolerance, 16-bit ADC operation, unless otherwise specified.



**Electrical Specifications**  $V_{DD} = 3.0V$ ,  $T_A = +25$  °C,  $R_{EXT} = 499k\Omega$  1% tolerance, 16-bit ADC operation, unless otherwise specified. (Continued)

PARAMETER	DESCRIPTION	TEST CONDITIONS	MIN ( <u>Note 6</u> )	ТҮР	MAX ( <u>Note 6</u> )	UNIT
V <sub>REF</sub>	Voltage of R <sub>EXT</sub> Pin			0.52		v
V <sub>IL</sub>	SCL and SDA Input Low Voltage				0.55	v
V <sub>IH</sub>	SCL and SDA Input High Voltage		1.25			v
I <sub>SDA</sub>	SDA Current Sinking Capability	V <sub>OL</sub> = 0.4V	4	5		mA
IINT	INT Current Sinking Capability	V <sub>OL</sub> = 0.4V	4	5		mA

#### **Electrical Specifications** VDD = 3.0V, TA = +25 °C, R<sub>EXT</sub> = 1MΩ 1% tolerance, 16-bit ADC operation, unless otherwise specified.

PARAMETER	DESCRIPTION	TEST CONDITIONS	MIN ( <u>Note 6</u> )	ТҮР	MAX ( <u>Note 6</u> )	UNIT
V <sub>DD</sub>	Power Supply Range		2.25		3.63	v
I <sub>DD</sub>	Supply Current			42	50	μA
I <sub>DD1</sub>	Supply Current when Powered Down	Software disabled or auto power-down		0.01	0.3	μΑ
VI2C	Supply Voltage Range for I <sup>2</sup> C Interface		1.70		3.63	v
fosc	Internal Oscillator Frequency		305	340	385	kHz
t <sub>INT</sub>	ADC Integration/Conversion Time	16-bit ADC data		200		ms
F <sub>I2C</sub>	I <sup>2</sup> C Clock Rate Range			1 to 400		kHz
DATA_0	Count Output when Dark	E = 0 lux, Range 1 (125 lux)		1	10	Counts
DATA_F	Full Scale ADC Code				65535	Counts
DATA	Count Output Variation Over Three Light Sources: Fluorescent, Incandescent and Sunlight	Ambient Light Sensing		±10		%
DATA_1	Light Count Output with LSB of 0.00095 lux/Count	E = 18.75 lux, fluorescent light ( <u>Note 7</u> ), ambient light sensing, Range 1 (62.5 lux)	15000	20000	25000	Counts
DATA_2	Light Count Output with LSB of 0.000375 lux/Count	E = 18.75 lux, fluorescent light ( <u>Note 7</u> ), ambient light sensing, Range 2 (250 lux)		5000		Counts
DATA_3	Light Count Output with LSB of 0.015 lux/Count	E = 18.75 lux, fluorescent light ( <u>Note 7</u> ), ambient light sensing, Range 3 (1k lux)		1250		Counts
DATA_4	Light Count Output with LSB of 0.6 lux/Count	E = 18.75 lux, fluorescent light ( <u>Note 7</u> ), ambient light sensing, Range 4 (4k lux)		312		Counts
DATA_IR1	Infrared Count Output	E = 10 lux solar light ( <u>Note 8</u> ), ambient light sensing, Range 1 (62.5 lux)	15000	20000	25000	Counts
DATA_IR2	Infrared Count Output	E = 10 lux solar light ( <u>Note 8</u> ), ambient light sensing, Range 2 (250 lux)		5000		Counts
DATA_IR3	Infrared Count Output	E = 10 lux solar light ( <u>Note 8</u> ), ambient light sensing, Range 3 (1000 lux)		1250		Counts
DATA_IR4	Infrared Count Output	E = 10 lux solar light ( <u>Note 8</u> ), ambient light sensing, Range 4 (4000 lux)		312		Counts
V <sub>REF</sub>	Voltage of R <sub>EXT</sub> Pin			0.52		v
V <sub>IL</sub>	SCL and SDA Input Low Voltage				0.55	v
V <sub>IH</sub>	SCL and SDA Input High Voltage		1.25			v
I <sub>SDA</sub>	SDA Current Sinking Capability	V <sub>OL</sub> = 0.4V	4	5		mA
IINT	INT Current Sinking Capability	V <sub>OL</sub> = 0.4V	4	5		mA



PARAMETER	DESCRIPTION	TEST CONDITIONS	MIN ( <u>Note 6</u> )	ТҮР	MAX ( <u>Note 6</u> )	UNIT
VI2C	Supply Voltage Range for I <sup>2</sup> C Interface		1.7		3.63	۷
fSCL	SCL Clock Frequency				400	kHz
V <sub>IL</sub>	SCL and SDA Input Low Voltage				0.55	۷
VIH	SCL and SDA Input High Voltage		1.25			۷
V <sub>hys</sub>	Hysteresis of Schmitt Trigger Input		0.05V <sub>DD</sub>			۷
V <sub>OL</sub>	Low-Level Output Voltage (Open-Drain) at 4mA Sink Current				0.4	v
li	Input Leakage for each SDA, SCL Pin		-10		10	μA
t <sub>SP</sub>	Pulse Width of Spikes that must be Suppressed by the Input Filter				50	ns
t <sub>AA</sub>	SCL Falling Edge to SDA Output Data Valid				900	ns
Ci	Capacitance for each SDA and SCL Pin				10	pF
<sup>t</sup> HD:STA	Hold Time (Repeated) START Condition	After this period, the first clock pulse is generated.	600			ns
t <sub>LOW</sub>	LOW Period of the SCL Clock	Measured at the 30% of $\mathrm{V}_{\mathrm{DD}}$ crossing	1300			ns
thigh	HIGH Period of the SCL Clock		600			ns
<sup>t</sup> su:sta	Set-up Time for a Repeated START Condition		600			ns
t <sub>HD:DAT</sub>	Data Hold Time		30			ns
t <sub>SU:DAT</sub>	Data Set-Up Time		100			ns
t <sub>R</sub>	Rise Time of Both SDA and SCL Signals	( <u>Note 9</u> )	20 + 0.1xC <sub>b</sub>			ns
t <sub>F</sub>	Fall Time of Both SDA and SCL Signals	( <u>Note 9</u> )	20 + 0.1xC <sub>b</sub>			ns
t <sub>SU:STO</sub>	Set-Up Time for STOP Condition		600			ns
<sup>t</sup> BUF	Bus Free Time Between a STOP and START Condition		1300			ns
C <sub>b</sub>	Capacitive Load for Each Bus Line				400	pF
R <sub>pull-up</sub>	SDA and SCL System Bus Pull-Up Resistor	Maximum is determined by ${\rm t}_{\rm R}$ and ${\rm t}_{\rm F}$	1			kΩ
t <sub>VD;DAT</sub>	Data Valid Time				0.9	μs
t <sub>VD:ACK</sub>	Data Valid Acknowledge Time				0.9	μs
v <sub>nL</sub>	Noise Margin at the LOW Level		0.1V <sub>DD</sub>			v
V <sub>nH</sub>	Noise Margin at the HIGH Level		0.2V <sub>DD</sub>			v

**I**<sup>2</sup>**C Electrical Specifications** For SCL and SDA (Figure 2), unless otherwise noted,  $V_{DD} = 3V$ ,  $T_A = +25$ °C,  $R_{EXT} = 499k\Omega 1\%$  and  $1M\Omega 1\%$  tolerance.

NOTE:

6. Compliance to datasheet limits is assured by one or more methods: production test, characterization, and/or design.

7. A 550nm green LED is used in production test. The 550nm LED irradiance is calibrated to produce the same DATA count as a fluorescent light with illuminance at the stated lux.

8. An 850nm IR LED is used in production test. The 850nm LED irradiance is calibrated to produce the same DATA\_IR count as solar light with illuminance at the stated lux.

9.  $\rm C_b$  is the capacitance of the bus in pF.



## **Principles of Operation**

### **Photodiodes and ADC**

The ISL29033 contains two photodiode arrays that convert light into current. The spectral response for ambient light sensing and infrared (IR) sensing is shown in Figure 8 on page 12. After light is converted to current during the light signal process, the current output is converted to digital by a built-in 16-bit Analog-to-Digital Converter (ADC). An I<sup>2</sup>C command reads the ambient light or IR intensity in counts.

The converter is a charge-balancing integrating type 16-bit ADC. The chosen method for conversion is best for converting small current signals in the presence of an AC periodic noise. A 100ms integration time, for instance, highly rejects a 50Hz and 60Hz power line noise simultaneously. <u>See "Integration and</u> <u>Conversion Time" on page 9.</u>

The built-in ADC offers user flexibility in integration time or conversion time. There are two timing modes: Internal timing mode and external timing mode. In internal timing mode, integration time is determined by an internal oscillator ( $f_{OSC}$ ) and the n-bit (n = 4, 8, 12, 16) counter inside the ADC. In external timing mode, integration time is determined by the time between two consecutive I<sup>2</sup>C External Timing Mode commands. A good balance of integration time and resolution (depending on application) is required for optimal results.

The ADC has an  $I^2C$  programmable range select to dynamically accommodate various lighting conditions. For very dim conditions, the ADC can be configured at its lowest range (Range 1) in the ambient light sensing.

### **Low-Power Operation**

The ISL29033 initial operation is at the power-down mode after a supply voltage is provided. The data registers contain the default value of 0. When the ISL29033 receives an  $I^2C$  command to do a one-time measurement from an  $I^2C$  master, it starts an ADC conversion with light sensing. It goes to power-down mode automatically after one conversion is finished and keeps the conversion data available for the master to fetch anytime afterwards. The ISL29033 continuously does the ADC conversion with light sensing if it receives an  $I^2C$  command of continuous measurement. It continuously updates the data registers with the latest conversion data. The ISL29033 goes to power-down mode after it receives the  $I^2C$  command of power-down.

### **Ambient Light**

There are two operational modes in ISL29033: programmable continuous ALS sensing and programmable continuous IR sensing. These two modes can be programmed in series to fulfill the application needs. The detailed program configuration is shown in the Figure 1 on page 1.

When the part is programmed for ambient light sensing, the ambient light with wavelength within the "Ambient Light Sensing" spectral response curve in <u>Figure 8</u> is converted into current. With ADC, the current is converted to an unsigned n-bit (up to 16 bits) digital output.

When the part is programmed for infrared (IR) sensing, the IR light with wavelength within the "IR Sensing" spectral response

curve in <u>Figure 8</u> is converted into current. With ADC, the current is converted to an unsigned n-bit (up to 16 bits) digital output.

### **Interrupt Function**

The active low-interrupt pin is an open-drain pull-down configuration. The interrupt pin serves as an alarm or monitoring function to determine whether the ambient light level exceeds the upper threshold or goes below the lower threshold. Note that the function of ADC conversion continues without stopping after interrupt is asserted. If the user needs to read the ADC count that triggers the interrupt, reading should be done before the data registers are refreshed by subsequent conversions. The user can also configure the persistency of the interrupt pin. This reduces the possibility of false triggers, such as noise or sudden spikes in ambient light conditions. An unexpected camera flash, for example, can be ignored by setting the persistency to eight integration cycles.

### **ALS Ranges Considerations**

When measuring ALS counts higher than 30000 counts on Range 1 of the 16-bit ADC, switch to Range 2 (change [1 to 0] bits of Register 1 from 00 to 01) and remeasure the ALS counts and other data to change to Range 3 and Range 4. This recommendation pertains only to applications in which light incident on the sensor is IR-heavy and is distorted by tinted glass that *increases* the ratio of infrared to visible light.

### V<sub>DD</sub> Power-Up and Power Supply Considerations

Upon power-up, ensure a V<sub>DD</sub> slew rate of 0.5V/ms or greater. After power-up, or if the power supply temporarily deviates from specification (2.25V to 3.63V), the following step is recommended: write 0x00 to register 0x00. Wait a few seconds and then rewrite all registers to the desired values. A hardware reset method can be used, if preferred, instead of writing to the test registers. For this method, set V<sub>DD</sub> = 0V for 1 second or more, power back up at the required slew rate and write the registers to the desired values.

### **Power-Down**

To put the ISL29033 into a power-down state, the user can set [7 to 5] bits to 0 in Register 0. Or more simply, set all of Register 0 to 0x00.

### I<sup>2</sup>C Interface

There are eight 8-bit registers available inside the ISL29033. The two command registers define the operation of the device. The command registers do not change until the registers are overwritten. The two 8-bit data read-only registers are for the ADC output. The data registers contain the ADC's latest digital output, or the number of clock cycles in the previous integration period (Figure 2 on page 7).

The ISL29033 I<sup>2</sup>C interface slave address is internally hard-wired as 1000100. When 1000100x, with x as R or  $\overline{W}$ , is sent after the start condition, the device compares the first seven bits of this byte to its address and matches. Figure 3 on page 7 shows a sample one-byte read and Figure 4 on page 8 shows a sample one-byte write. The I<sup>2</sup>C bus master always drives the SCL (clock) line, while either the master or the slave can drive the SDA (data) line. Every I<sup>2</sup>C



transaction begins with the master asserting a start condition (SDA falling while SCL remains high). The following byte is driven by the master and includes the slave address and the read/write bit. The receiving device is responsible for pulling SDA low during the acknowledgment period. Every  $I^2C$  transaction ends with the master asserting a stop condition (SDA rising while SCL remains high).

For more information about the I<sup>2</sup>C standard, consult the Philips<sup>TM</sup> I<sup>2</sup>C specification documents.

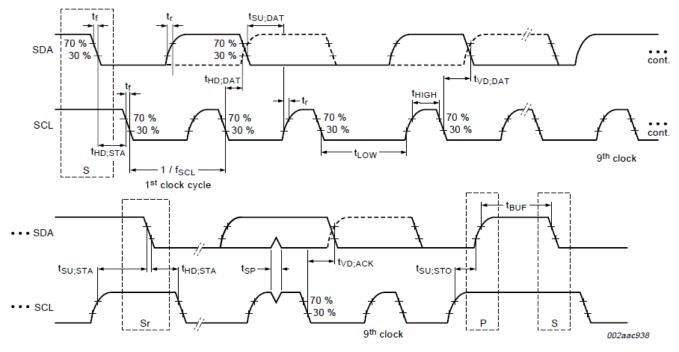


FIGURE 2. I<sup>2</sup>C TIMING DIAGRAM

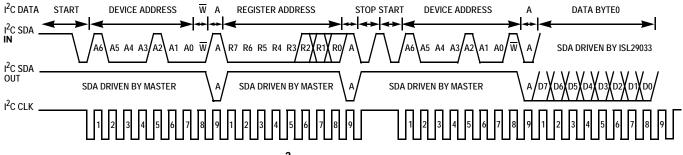
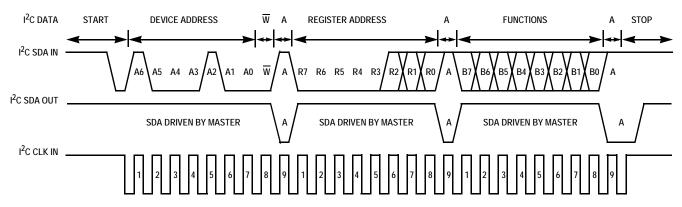


FIGURE 3. I<sup>2</sup>C READ TIMING DIAGRAM SAMPLE



#### FIGURE 4. I<sup>2</sup>C WRITE TIMING DIAGRAM SAMPLE

	TABLE 1. REGISTER SET									
			BIT							
ADDR	REG NAME	7	6	5	4	3	2	1	0	DEFAULT
00h	COMMANDI	0P2	0P1	0P0	0	0	FLAG	PRST1	PRST0	00h
01h	COMMANDII	0	0	0	0	RES1	RES0	RANGE 1	RANGE 0	00h
02h	DATA <sub>LSB</sub>	D7	D6	D5	D4	D3	D2	D1	DO	00h
03h	DATA <sub>MSB</sub>	D15	D14	D13	D12	D11	D10	D9	D8	00h
04h	INT_LT_LSB	TL7	TL6	TL5	TL4	TL3	TL2	TL1	TLO	00h
05h	INT_LT_MSB	TL15	TL14	TL13	TL12	TL11	TL10	TL9	TL8	00h
06h	INT_HT_LSB	TH7	TH6	TH5	TH4	тнз	TH2	TH1	THO	FFh
07h	INT_HT_MSB	TH15	TH14	TH13	TH12	TH11	TH10	тн9	TH8	FFh

### **Register Set**

There are eight registers available in the ISL29033. <u>Table 1</u> summarizes their functions.

### **Command Register I 00 (Hex)**

The first command register has the following functions:

- 1. Operation Mode: Bits 7, 6 and 5. These three bits determine the operation mode of the device (<u>Table 2</u>).
- 2. Interrupt flag: Bit 2. This is the status bit of the interrupt (Table 3). The bit is set to logic high when the interrupt thresholds have been triggered (out of threshold window) and to logic low when not yet triggered. When activated and the interrupt is triggered, the  $\overline{INT}$  pin goes low and the interrupt status bit goes high until the status bit is polled through the  $I^2C$  read command. Both the  $\overline{INT}$  output and the interrupt status bit are automatically cleared at the end of the 8-bit (00h) command register transfer.
- 3. Interrupt Persist: Bits 1 and 0. The interrupt pin and the interrupt flag are triggered or set when the data sensor reading is out of the interrupt threshold window after m consecutive number of integration cycles (<u>Table 4 on page 9</u>). The interrupt persist bits determine m.

#### TABLE 2. OPERATION MODE

BITS 7 TO 5	OPERATION
000	Power-down the device
001	Reserved (do not use)
010	Reserved (do not use)
100	Reserved (do not use)
101	ALS continuous
110	IR continuous
111	Reserved (do not use)

#### TABLE 3. INTERRUPT FLAG

BIT 2	OPERATION
0	Interrupt is cleared or not triggered yet
1	Interrupt is triggered



#### TABLE 4. INTERRUPT PERSIST

BIT 1:0	NUMBER OF INTEGRATION CYCLES
00	1
01	4
10	8
11	16

#### **Command Register II 01 (Hex)**

The second command register has the following functions:

- Resolution: Bits 3 and 2. Bits 3 and 2 determine the ADC resolution and the number of clock cycles per conversion (<u>Table 5</u>). Changing the number of clock cycles does more than just change the resolution of the device; it also changes the integration time, which is the period during which the Analog-to-Digital (A/D) converter samples the photodiode current signal for a measurement.
- 2. Range: Bits 1 and 0. The Full Scale Range (FSR) can be adjusted through the I<sup>2</sup>C by using Bits 1 and 0. <u>Table 6</u> lists the possible values of FSR for the 499k $\Omega$  R<sub>EXT</sub> resistor.

BITS 3:2	NUMBER OF CLOCK CYCLES	n-BIT ADC
00	2 <sup>16</sup> = 65,536	16
01	2 <sup>12</sup> = 4,096	12
10	2 <sup>8</sup> = 256	8
11	2 <sup>4</sup> = 16	4

TABLE 5. ADC RESOLUTION DATA WIDTH

BITS 1:0	k	RANGE(k)	FSR (lux) AT ALS SENSING
00	1	Range1	125
01	2	Range2	500
10	3	Range3	2,000
11	4	Range4	8,000

### Data Registers (02 Hex and 03 Hex)

The device has two 8-bit read-only registers to hold the data from LSB to MSB for the ADC (<u>Table 7</u>). The Most Significant Bit (MSB) is accessed at 03 hex and the Least Significant Bit (LSB) is accessed at 02 hex. For 16-bit resolution, the data is from D0 to D15; for 12-bit resolution, the data is from D0 to D11; for 8-bit resolution, the data is from D0 to D7. The registers are refreshed after every conversion cycle.

	DATA	DEOLOTEDO
IADLE /.	DAIA	REGISTERS

ADDRESS (HEX)	CONTENTS
02	D0 is LSB for 4-, 8-, 12- or 16-bit resolution; D3 is MSB for 4-bit resolution; D7 is MSB for 8-bit resolution
03	D15 is MSB for 16-bit resolution; D11 is MSB for 12-bit resolution

#### Interrupt Registers (04, 05, 06, and 07 Hex)

Registers 04 and 05 hex set the Low (LO) threshold for the interrupt pin and the interrupt flag. Register 04 hex is the LSB and Register 05 hex is the MSB. By default, the interrupt threshold LO is 00 hex for both LSB and MSB.

Registers 06 and 07 hex set the High (HI) threshold for the interrupt pin and the interrupt flag. Register 06 hex is the LSB and Register 07 hex is the MSB. By default, the interrupt threshold HI is FF hex for both LSB and MSB.

#### **Calculating Lux**

The ISL29033 ADC output codes, DATA, are directly proportional to lux in ambient light sensing, as shown in <u>Equation 1</u>.

$$E_{cal} = \alpha \times DATA$$
 (EQ. 1)

In this equation,  $E_{cal}$  is the calculated lux reading. The constant,  $\alpha$ , is determined by the full scale range and the ADC maximum output counts. The constant is independent of the light sources (fluorescent, incandescent, and sunlight) because the light source IR component is removed during the light signal process. The constant can also be viewed as the sensitivity (the smallest lux measurement the device can measure), as shown in Equation 2.

$$\alpha = \frac{\text{Range}(k)}{\text{Count}_{\text{max}}}$$
(EQ. 2)

In this equation, Range(k) is as defined in <u>Table 6</u>. Count<sub>max</sub> is the maximum output counts from the ADC.

The transfer function used for n-bits ADC is as shown in Equation 3:

$$E_{cal} = \frac{Range(k)}{2^{n}} \times DATA$$
 (EQ. 3)

In this equation, n = 4, 8, 12 or 16 and is the number of ADC bits programmed in the command register. The number  $2^n$ represents the maximum number of counts possible from the ADC output. Data is the ADC output stored in data Registers 02 hex and 03 hex.

#### Integration and Conversion Time

ADC resolution and  $f_{OSC}$  determine the integration time,  $t_{int}$ , as shown in Equation 4.

$$t_{int} = 2^{n} \times \frac{1}{f_{OSC}} = 2^{n} \times \frac{R_{EXT}}{655 \text{kHz} \times 499 \text{k}\Omega}$$
(EQ. 4)

In this equation, n is the number of bits of resolution and n = 4, 8, 12 or 16. Therefore,  $2^n$  is the number of clock cycles. The value of n can be programmed at the command register, Register 01 hex, Bits 3 and 2 see (Table 8).

TABLE 8.	INTEGRATION	TIME OF	n-BIT ADC

R <sub>EXT</sub> (kΩ)	n = 16-BIT (ms)	n = 12-BIT (ms)	n <b>= 8-BIT</b> (µs)	n <b>= 4-</b> BIT (µs)
499	100	6.25	391	24
1000	200	12.5	782	48

TABLE 6.	RANGE/FSR LU	х
	,	

# External Scaling Resistor $\mathbf{R}_{\text{EXT}}$ for $\mathbf{f}_{\text{OSC}}$ and Range

The ISL29033 uses an external resistor, R<sub>EXT</sub>, to fix its internal oscillator frequency,  $f_{OSC}$ , and the light sensing range, Range. The  $f_{OSC}$  and Range are inversely proportional to R<sub>EXT</sub>. For ease of use, the proportionality constant is referenced to 499k $\Omega$ . Calculation for Range is shown in <u>Equation 5</u> and for  $f_{OSC}$  in <u>Equation 6</u>.

Range = 
$$\frac{499k\Omega}{R_{EXT}} \times Range(k)$$
 (EQ. 5)

$$f_{OSC} = \frac{499k\Omega}{R_{EXT}} \times 655 \text{kHz}$$
 (EQ. 6)

### **Noise Rejection**

In general, integrating-type ADCs have excellent noise rejection characteristics for periodic noise sources for which, frequency is an integer multiple of the conversion rate. For example, a 60Hz AC unwanted signal's sum from 0ms to k\*16.66ms (k = 1, 2...k<sub>j</sub>) is zero. Similarly, setting the device's integration time to be an integer multiple of the periodic noise signal greatly improves the light sensor output signal in the presence of noise.

### **ADC Output in IR Sensing**

The ISL29033 ADC output codes, DATA, are directly proportional to the IR intensity received in IR sensing, as shown in <u>Equation 7</u>.

$$\mathsf{DATA}_{\mathsf{IR}} = \beta \times \mathsf{E}_{\mathsf{IR}} \tag{EQ. 7}$$

In this equation,  $E_{IR}$  is the received IR intensity. The constant,  $\beta$ , changes with the spectrum of background IR noise, such as sunlight and incandescent light. The constant,  $\beta$ , also changes with ADC range and resolution selections.

### **Suggested PCB Footprint**

It is important that users check <u>TB477</u>, "Surface Mount Assembly Guidelines for Optical Dual FlatPack No Lead (ODFN) Package" before starting ODFN product board mounting.

#### **Layout Considerations**

The ISL29033 is relatively insensitive to layout. Like other I<sup>2</sup>C devices, it is intended to provide excellent performance even in significantly noisy environments. Attention to a few considerations will ensure best performance.

Route the supply and I<sup>2</sup>C traces as far as possible from all sources of noise. Use two power-supply decoupling capacitors, 1µF and 0.1µF, placed close to the device.

### **Typical Circuit**

A typical application for the ISL29033 is shown in Figure 5. The ISL29033 I<sup>2</sup>C address is internally hardwired as 1000100. The device can be tied onto a system's I<sup>2</sup>C bus together with other I<sup>2</sup>C-compliant devices.

#### **Soldering Considerations**

Convection heating is recommended for reflow soldering; direct-infrared heating is not recommended. The plastic ODFN package does not require a custom reflow soldering profile; it is qualified to +260°C. A standard reflow soldering profile with a +260°C maximum is recommended.

#### **ALS Sensor Window Layout**

Special care should be taken to ensure that the sensor, as shown in the sensor location outline (<u>Figure 6 on page 11</u>), is uniformly illuminated. Shadows from off-angle window openings can affect uniform illumination, which in turn can affect measurement

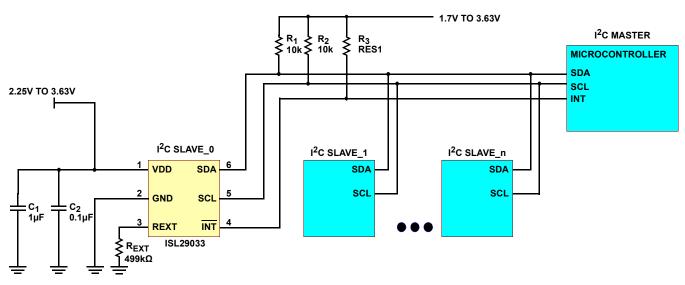


FIGURE 5. ISL29033 TYPICAL CIRCUIT



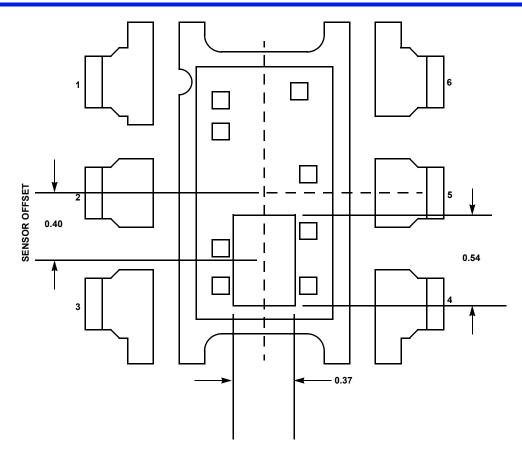


FIGURE 6. 6 LD ODFN SENSOR LOCATION OUTLINE



### Typical Performance Curves $v_{DD} = 3.0V$ , $R_{EXT} = 499 k\Omega$ .

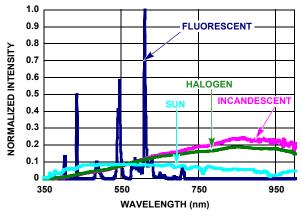


FIGURE 7. SPECTRUM OF FOUR LIGHT SOURCES NORMALIZED BY LUMINOUS INTENSITY (lux)

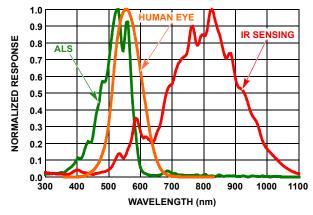


FIGURE 8. NORMALIZED SPECTRAL RESPONSE FOR AMBIENT LIGHT SENSING

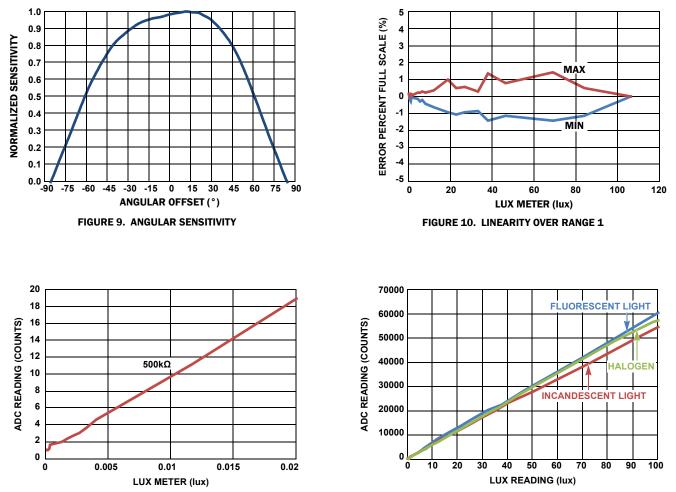


FIGURE 11. LOW LUX AT GREEN LED (500kΩ)

FIGURE 12. LIGHT SOURCES AT RANGE 1, 500k Rext



## **Typical Performance Curves** $v_{DD} = 3.0V, R_{EXT} = 499k\Omega.$ (Continued)

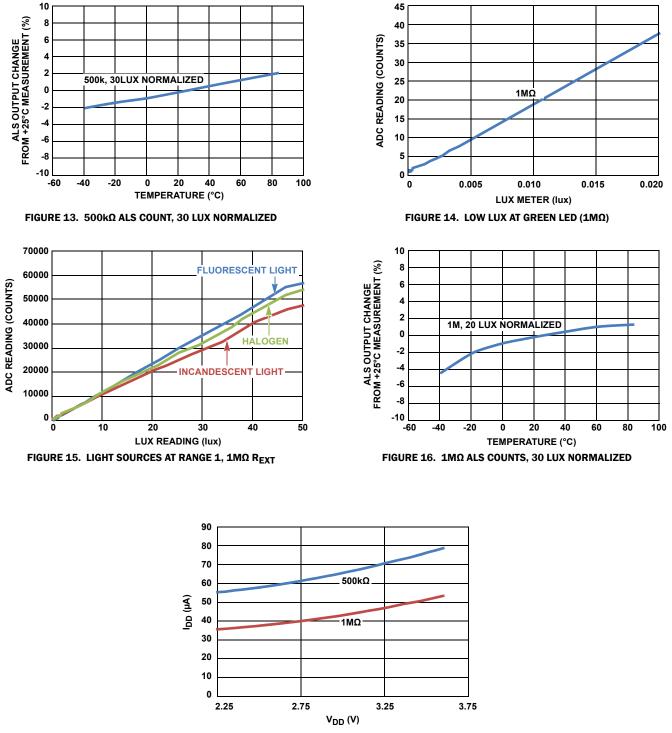


FIGURE 17. SUPPLY CURRENT vs VDD ALS SENSING



# **Revision History** The revision history provided is for informational purposes only and is believed to be accurate, but not warranted. Visit our website to make sure you have the latest revision.

DATE REVISION		CHANGE	
September 28, 2016	FN7656.5	Updated Related Literature section. Updated Pin Configuration title changed "Bottom View" to "Top View".	
April 21, 2016	FN7656.4	Removed AN1422 reference on page 1.	
December 16, 2015	FN7656.3	Ambient Light on page 6: Removed mention of "once mode" in Principles of Operation/Ambient Light. Command Register I 00 (Hex) on page 8: Split section 1 under Register Set/Command Register I into 2 sections. Updated POD L6.2x2.1 to most current version changes are as follows: Change Note 5 From: Tiebar shown (if present) is a non-functional feature. To: Tiebar shown (if present) is a non-functional feature and may be located on any of the 4 sides (or ends). Updated Arrows to correct arrow type.	
September 26, 2012	FN7656.2	Corrected horizontal axis in Figure 9 on page 12 from 0 to 40 to -90 to 90.	
September 21, 2011	FN7656.1	Changed Title on page 1 from "Integrated Digital Ambient Light Sensor with Interrupt Function" to "Ultra-Low Lux, Low Power, Integrated Digital Ambient Light Sensor with Interrupt Function"	
August 25, 2011	FN7656.0	Initial Release	

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## **Package Outline Drawing**

L6.2x2.1

6

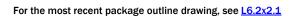
PIN 1 INDEX AREA

(4X) 🛆 0.10

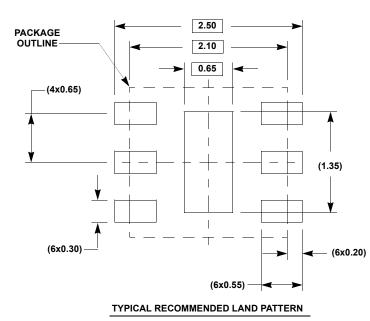
6 LEAD OPTICAL DUAL FLAT NO-LEAD PLASTIC PACKAGE (ODFN) Rev 4, 2/15

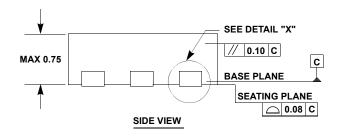
2.10

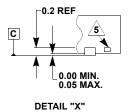
TOP VIEW



BOTTOM VIEW







NOTES:

- 1. Dimensions are in millimeters. Dimensions in ( ) for Reference Only.
- 2. Dimensioning and tolerancing conform to ASME Y14.5m-1994.
- 3. Unless otherwise specified, tolerance: Decimal ± 0.05
- **<u>A</u>** Dimension applies to the metallized terminal and is measured between 0.15mm and 0.30mm from the terminal tip.

**Tiebar shown (if present) is a non-functional feature and maybe located on any of the 4 sides (or ends).** 

<u>A</u> The configuration of the pin #1 identifier is optional, but must be located within the zone indicated. The pin #1 identifier may be either a mold or mark feature.



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